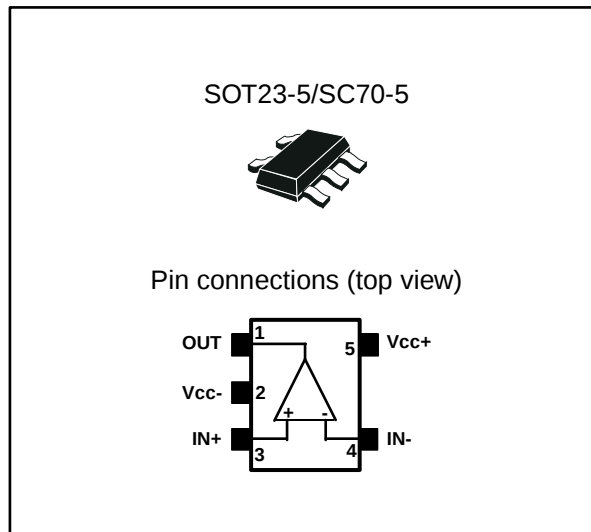


Rail-to-rail 1.8 V high-speed comparator

Datasheet - production data



Features

- Propagation delay: 38 ns
- Low current consumption: 73 μ A
- Rail-to-rail inputs
- Push-pull outputs
- Supply operation from 1.8 to 5 V
- Wide temperature range: -40 °C to 125 °C
- High ESD tolerance: 5 kV HBM, 300 V MM
- Latch-up immunity: 200 mA
- SMD packages
- Automotive qualification

Related products

- TS3022 for a dual comparator with similar performances
- TS3011 for a high-speed comparator

Applications

- Telecom
- Instrumentation
- Signal conditioning
- High-speed sampling systems
- Portable communication systems

Description

The TS3021 single comparator features high-speed response time with rail-to-rail inputs. With a supply voltage specified from 2 to 5 V, this comparator can operate over a wide temperature range: -40 °C to 125 °C.

The TS3021 comparator offers micropower consumption as low as a few tens of microamperes thus providing an excellent ratio of power consumption current versus response time.

The TS3021 includes push-pull outputs and is available in small packages (SOT23-5 and SC70-5).

Contents

1	Absolute maximum ratings and operating conditions	3
2	Electrical characteristics	4
3	Package information	15
3.1	SOT23-5 package information	16
3.2	SC70-5 (or SOT323-5) package information.....	17
4	Ordering information.....	18
5	Revision history	19

1 Absolute maximum ratings and operating conditions

Table 1: Absolute maximum ratings (AMR)

Symbol	Parameter		Value	Unit
V_{CC}	Supply voltage, $V_{CC} = (V_{CC+}) - (V_{CC-})$ ⁽¹⁾		5.5	V
V_{ID}	Differential input voltage ⁽²⁾		±5	
V_{IN}	Input voltage range		$(V_{CC-}) - 0.3$ to $(V_{CC+}) + 0.3$	
R_{thja}	Thermal resistance junction-to-ambient ⁽³⁾	SOT23-5	250	°C/W
		SC70-5	205	
R_{thjc}	Thermal resistance junction-to-case ⁽³⁾	SOT23-5	81	
		SC70-5	172	
T_{stg}	Storage temperature		-65 to 150	°C
T_j	Junction temperature		150	
T_{LEAD}	Lead temperature (soldering 10 s)		260	
ESD	HBM: human body model ⁽⁴⁾		5000	V
	MM: machine model ⁽⁵⁾		300	
	CDM: charged device model ⁽⁶⁾		1500	
	Latch-up immunity		200	mA

Notes:

⁽¹⁾ All voltage values, except the differential voltage are referenced to (V_{CC-})

⁽²⁾ The magnitude of the input and output voltages must never exceed the supply rail ±0.3 V

⁽³⁾ Short circuits can cause excessive heating. These values are typical

⁽⁴⁾ Human body model: a 100 pF capacitor is charged to the specified voltage, then discharged through a 1.5 kΩ resistor between two pins of the device. This is done for all couples of connected pin combinations while the other pins are floating.

⁽⁵⁾ Machine model: a 200 pF capacitor is charged to the specified voltage, then discharged directly between two pins of the device with no external series resistor (internal resistor < 5 Ω). This is done for all couples of connected pin combinations while the other pins are floating.

⁽⁶⁾ Charged device model: all pins and the package are charged together to the specified voltage and then discharged directly to the ground through only one pin. This is done for all pins.

Table 2: Operating conditions

Symbol	Parameter		Value	Unit
V_{CC}	Supply voltage	0 °C < T_{amb} < 125 °C	1.8 to 5	V
		-40 °C < T_{amb} < 125 °C	2 to 5	
V_{icm}	Common mode input voltage range	-40 °C < T_{amb} < 85 °C	$(V_{CC-}) - 0.2$ to $(V_{CC+}) + 0.2$	
		85 °C < T_{amb} < 125 °C	(V_{CC-}) to (V_{CC+})	
T_{oper}	Operating temperature range		-40 to 125	°C

2 Electrical characteristics

Table 3: Electrical characteristics at VCC = 2 V, Tamb = 25 °C, and full Vicm range (unless otherwise specified)

Symbol	Parameter	Test conditions ⁽¹⁾	Min.	Typ.	Max.	Unit
V _{IO}	Input offset voltage	Tamb (TS3021ILT, TS3021IYLT, TS3021ICT)		0.5	6	mV
		-40 °C < Tamb < 125 °C (TS3021ILT, TS3021IYLT, TS3021ICT)		0.5	7	
		Tamb (TS3021AILT)		0.5	2	
$\Delta V_{IO}/\Delta T$	Input offset voltage drift	-40 °C < Tamb < 125 °C		3	20	μV/°C
I _{IO}	Input offset current ⁽²⁾	Tamb		1	20	nA
		-40 °C < Tamb < 125 °C			100	
I _{IB}	Input bias current ⁽²⁾	Tamb		86	160	nA
		-40 °C < Tamb < 125 °C			300	
I _{CC}	Supply current	No load, output high, Vicm = 0 V		73	90	μA
		No load, output high, Vicm = 0 V, -40 °C < Tamb < 125 °C			115	
		No load, output low, Vicm = 0 V		84	105	
		No load, output low, Vicm = 0 V, -40 °C < Tamb < 125 °C			125	
I _{SC}	Short-circuit current	Source		9		mA
		Sink		10		
V _{OH}	Output voltage high	Is _{source} = 1 mA	1.88	1.92		V
		-40 °C < Tamb < 125 °C	1.80			
V _{OL}	Output voltage low	Is _{sink} = 1 mA		60	100	mV
		-40 °C < Tamb < 125 °C			150	
CMRR	Common mode rejection ratio	0 < Vicm < 2 V		67		dB
SVR	Supply voltage rejection	$\Delta V_{CC} = 2$ to 5 V	58	73		
TP _{LH}	Propagation delay, low to high output level ⁽³⁾	Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 100 mV		38	60	ns
		Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 20 mV		48	75	
TP _{HL}	Propagation delay, high to low output level ⁽⁴⁾	Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 100 mV		40	60	
		Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 20 mV		49	75	
T _F	Fall time	f = 10 kHz, CL = 50 pF, RL = 10 kΩ, overdrive = 100 mV		8		
T _R	Rise time	f = 10 kHz, CL = 50 pF, RL = 10 kΩ, overdrive = 100 mV		9		

Notes:

⁽¹⁾ All values over the temperature range are guaranteed through correlation and simulation. No production test is performed at the temperature range limits.

⁽²⁾ Maximum values include unavoidable inaccuracies of the industrial tests

⁽³⁾ Response time is measured 10%/90% of the final output value with the following conditions: inverting input voltage (IN-) = V_{icm} and non-inverting input voltage (IN+) moving from $V_{icm} - 100\text{ mV}$ to $V_{icm} + \text{overdrive}$.

⁽⁴⁾ Response time is measured 10%/90% of the final output value with the following conditions: Inverting input voltage (IN-) = V_{icm} and non-inverting input voltage (IN+) moving from $V_{icm} + 100\text{ mV}$ to $V_{icm} - \text{overdrive}$.

Table 4: Electrical characteristics at VCC = 3.3 V, Tamb = 25 ° C, and full Vicm range (unless otherwise specified)

Symbol	Parameter	Test conditions ⁽¹⁾	Min.	Typ.	Max.	Unit
V _{IO}	Input offset voltage	Tamb (TS3021ILT, TS3021IYLT, TS3021ICT)		0.2	6	mV
		-40 °C < Tamb < 125 °C (TS3021ILT, TS3021IYLT, TS3021ICT)		0.2	7	
		Tamb (TS3021AILT)		0.2	2	
$\Delta V_{IO}/\Delta T$	Input offset voltage drift	-40 °C < Tamb < 125 °C		3	20	$\mu V/^{\circ}C$
I _{IO}	Input offset current ⁽²⁾	Tamb		1	20	nA
		-40 °C < Tamb < 125 °C			100	
I _{IB}	Input bias current ⁽²⁾	Tamb		86	160	
		-40 °C < Tamb < 125 °C			300	
I _{CC}	Supply current	No load, output high, Vicm = 0 V		75	90	μA
		No load, output high, Vicm = 0 V, -40 °C < Tamb < 125 °C			120	
		No load, output low, Vicm = 0 V		86	110	
		No load, output low, Vicm = 0 V, -40 °C < Tamb < 125 °C			125	
I _{SC}	Short-circuit current	Source		26		mA
		Sink		24		
V _{OH}	Output voltage high	Is _{source} = 1 mA	3.20	3.25		V
		-40 °C < Tamb < 125 °C	3.10			
V _{OL}	Output voltage low	Is _{sink} = 1 mA		40	80	mV
		-40 °C < Tamb < 125 °C			150	
CMRR	Common mode rejection ratio	0 < Vicm < 3.3 V		75		dB
SVR	Supply voltage rejection	$\Delta V_{CC} = 2$ to 5 V	58	73		
TP _{LH}	Propagation delay, low to high output level ⁽³⁾	Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 100 mV		39	65	ns
		Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 20 mV		50	85	
TP _{HL}	Propagation delay, high to low output level ⁽⁴⁾	Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 100 mV		41	65	
		Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 20 mV		51	80	
T _F	Fall time	f = 10 kHz, CL = 50 pF, RL = 10 k Ω , overdrive = 100 mV		5		
T _R	Rise time	f = 10 kHz, CL = 50 pF, RL = 10 k Ω , overdrive = 100 mV		7		

Notes:

⁽¹⁾ All values over the temperature range are guaranteed through correlation and simulation. No production test is performed at the temperature range limits.

⁽²⁾ Maximum values include unavoidable inaccuracies of the industrial tests

⁽³⁾ Response time is measured 10%/90% of the final output value with the following conditions: inverting input voltage (IN-) = V_{icm} and non-inverting input voltage (IN+) moving from $V_{icm} - 100\text{ mV}$ to $V_{icm} + \text{overdrive}$.

⁽⁴⁾ Response time is measured 10%/90% of the final output value with the following conditions: Inverting input voltage (IN-) = V_{icm} and non-inverting input voltage (IN+) moving from $V_{icm} + 100\text{ mV}$ to $V_{icm} - \text{overdrive}$.

Table 5: Electrical characteristics at VCC = 5 V, Tamb = 25 °C, and full Vicm range (unless otherwise specified)

Symbol	Parameter	Test conditions ⁽¹⁾	Min.	Typ.	Max.	Unit
V _{IO}	Input offset voltage	Tamb (TS3021ILT, TS3021IYLT, TS3021ICT)		0.2	6	mV
		-40 °C < Tamb < 125 °C (TS3021ILT, TS3021IYLT, TS3021ICT)		0.2	7	
		Tamb (TS3021AILT)		0.2	2	
$\Delta V_{IO}/\Delta T$	Input offset voltage drift	-40 °C < Tamb < 125 °C		3	20	$\mu V/^{\circ}C$
I _{IO}	Input offset current ⁽²⁾	Tamb		1	20	nA
		-40 °C < Tamb < 125 °C			100	
I _{IB}	Input bias current ⁽²⁾	Tamb		86	160	
		-40 °C < Tamb < 125 °C			300	
I _{CC}	Supply current	No load, output high, Vicm = 0 V		77	95	μA
		No load, output high, Vicm = 0 V, -40 °C < Tamb < 125 °C			125	
		No load, output low, Vicm = 0 V		89	115	
		No load, output low, Vicm = 0 V, -40 °C < Tamb < 125 °C			135	
I _{SC}	Short-circuit current	Source		51		mA
		Sink		40		
V _{OH}	Output voltage high	Is _{source} = 4 mA	4.80	4.84		V
		-40 °C < Tamb < 125 °C	4.70			
V _{OL}	Output voltage low	Is _{sink} = 4 mA		130	180	mV
		-40 °C < Tamb < 125 °C			250	
CMRR	Common mode rejection ratio	0 < Vicm < 5 V		79		dB
SVR	Supply voltage rejection	$\Delta V_{CC} = 2$ to 5 V	58	73		
TP _{LH}	Propagation delay, low to high output level ⁽³⁾	Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 100 mV		42	75	ns
		Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 20 mV		54	105	
TP _{HL}	Propagation delay, high to low output level ⁽⁴⁾	Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 100 mV		45	75	
		Vicm = 0 V, f = 10 kHz, CL = 50 pF, overdrive = 20 mV		55	95	
T _F	Fall time	f = 10 kHz, CL = 50 pF, RL = 10 k Ω , overdrive = 100 mV		4		
T _R	Rise time	f = 10 kHz, CL = 50 pF, RL = 10 k Ω , overdrive = 100 mV		4		

Notes:

⁽¹⁾ All values over the temperature range are guaranteed through correlation and simulation. No production test is performed at the temperature range limits.

⁽²⁾ Maximum values include unavoidable inaccuracies of the industrial tests

⁽³⁾ Response time is measured 10%/90% of the final output value with the following conditions: inverting input voltage (IN-) = V_{icm} and non-inverting input voltage (IN+) moving from $V_{icm} - 100\text{ mV}$ to $V_{icm} + \text{overdrive}$.

⁽⁴⁾ Response time is measured 10%/90% of the final output value with the following conditions: Inverting input voltage (IN-) = V_{icm} and non-inverting input voltage (IN+) moving from $V_{icm} + 100\text{ mV}$ to $V_{icm} - \text{overdrive}$.

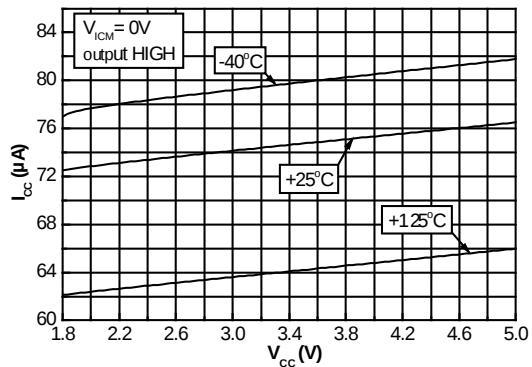
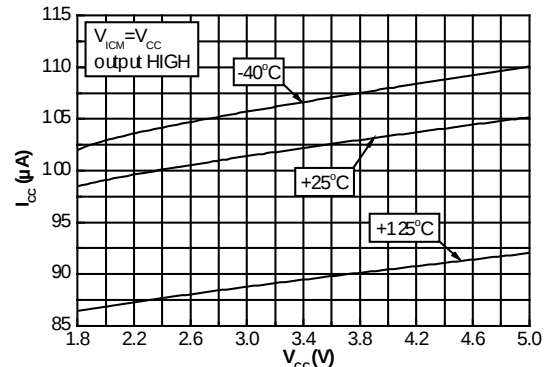
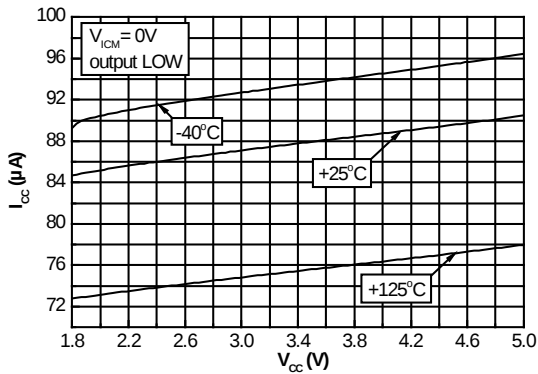
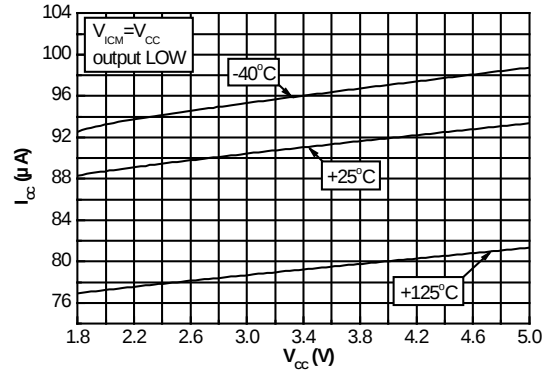
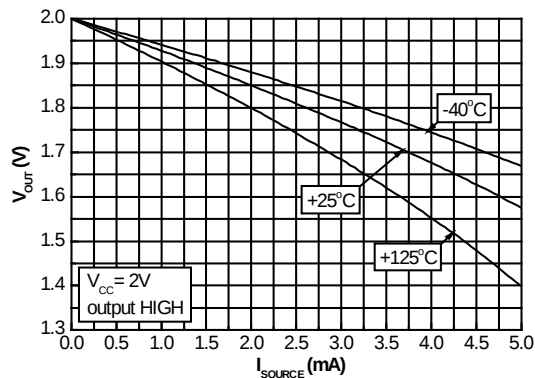
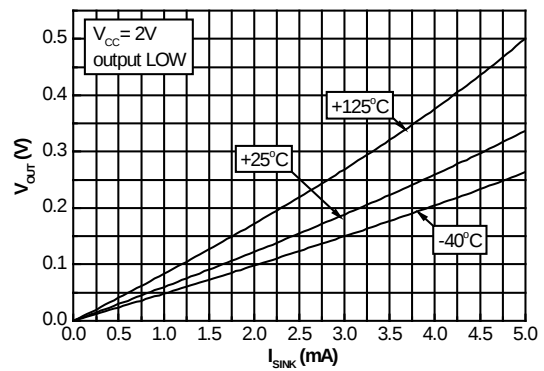
Figure 1: Current consumption vs. supply voltage
($V_{ICM} = 0\text{ V}$, output high)Figure 2: Current consumption vs. supply voltage
($V_{ICM} = V_{CC}$ output high)Figure 3: Current consumption vs. supply voltage
($V_{ICM} = 0\text{ V}$, output low)Figure 4: Current consumption vs. supply voltage
($V_{ICM} = V_{CC}$ output low)Figure 5: Output voltage vs. source current, $V_{CC} = 2\text{ V}$ Figure 6: Output voltage vs. sink current, $V_{CC} = 2\text{ V}$ 

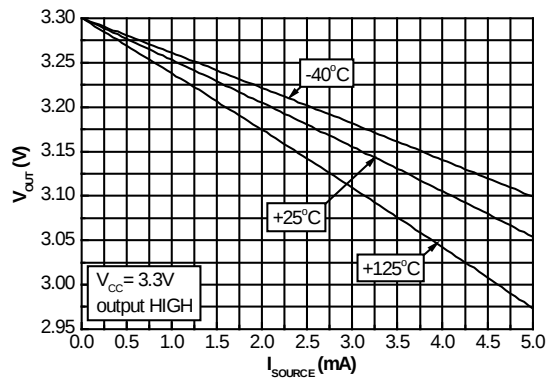
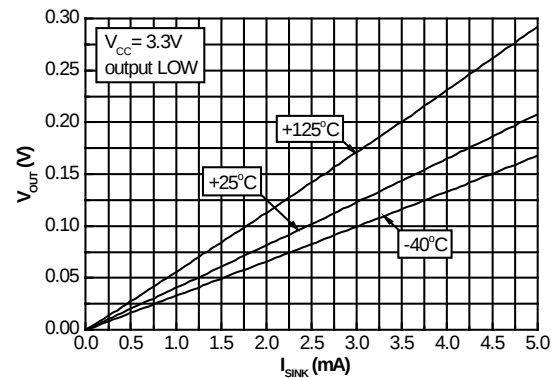
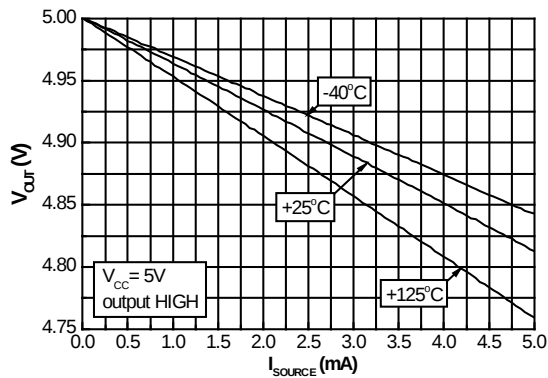
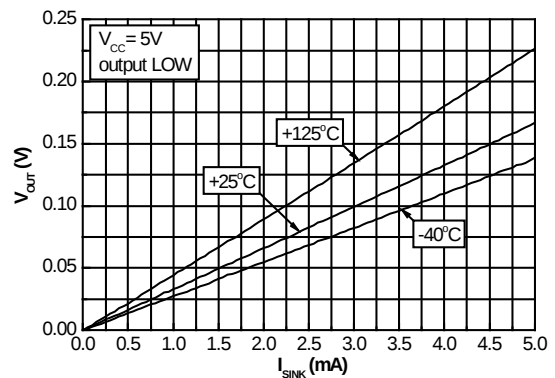
Figure 7: Output voltage vs. source current, $V_{CC} = 3.3\text{ V}$ Figure 8: Output voltage vs. sink current, $V_{CC} = 3.3\text{ V}$ Figure 9: Output voltage vs. source current, $V_{CC} = 5\text{ V}$ Figure 10: Output voltage vs. sink current, $V_{CC} = 5\text{ V}$ 

Figure 11: Input offset voltage vs. temperature and common mode voltage

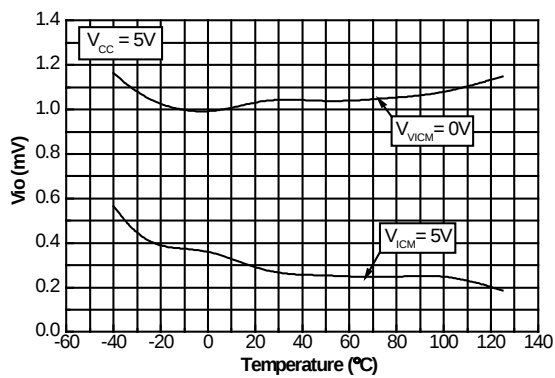


Figure 12: Input bias current vs. temperature and input voltage

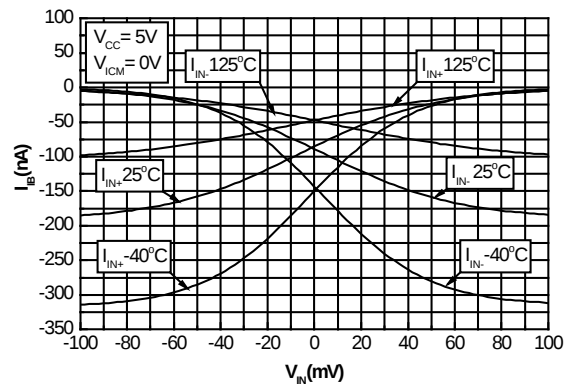


Figure 13: Current consumption vs. commutation frequency

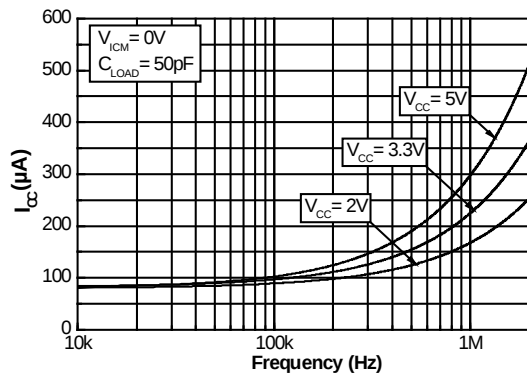
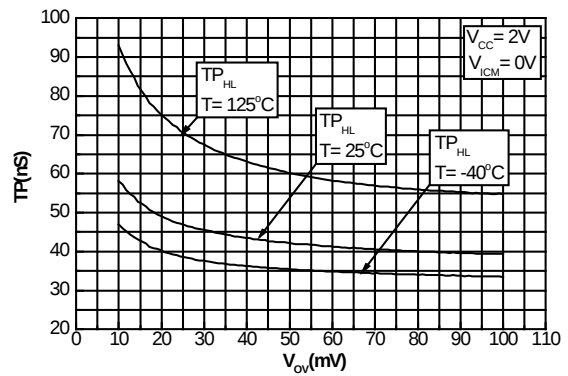
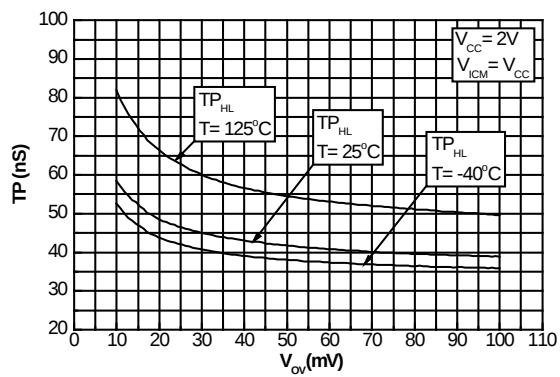
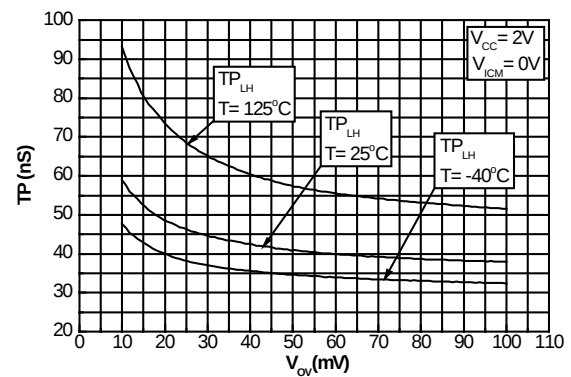
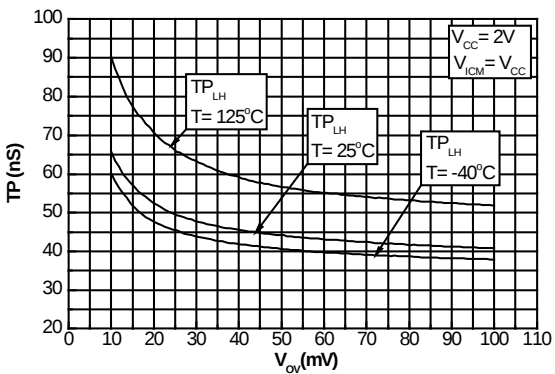
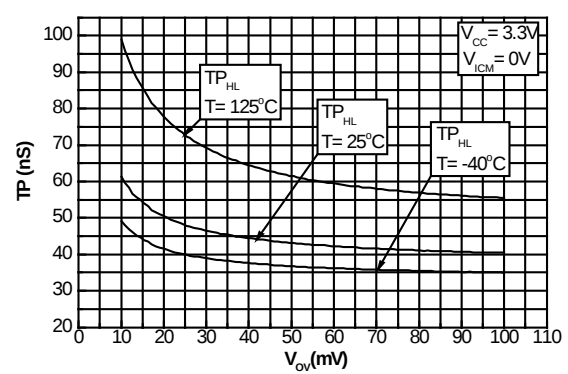
Figure 14: Propagation delay (HL) vs. overdrive at $V_{CC} = 2V$, $V_{ICM} = 0V$ Figure 15: Propagation delay (HL) vs. overdrive at $V_{CC} = 2V$, $V_{ICM} = V_{CC}$ Figure 16: Propagation delay (LH) vs. overdrive at $V_{CC} = 2V$, $V_{ICM} = 0V$ Figure 17: Propagation delay (LH) vs. overdrive at $V_{CC} = 2V$, $V_{ICM} = V_{CC}$ Figure 18: Propagation delay (HL) vs. overdrive at $V_{CC} = 3.3V$, $V_{ICM} = 0V$ 

Figure 19: Propagation delay (HL) vs. overdrive at $V_{CC} = 3.3\text{ V}$, $V_{ICM} = V_{CC}$

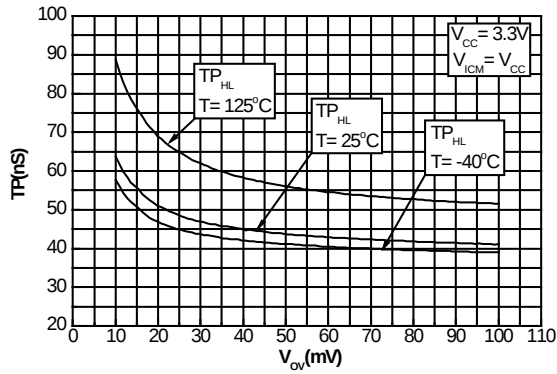


Figure 20: Propagation delay (LH) vs. overdrive at $V_{CC} = 3.3\text{ V}$, $V_{ICM} = 0\text{ V}$

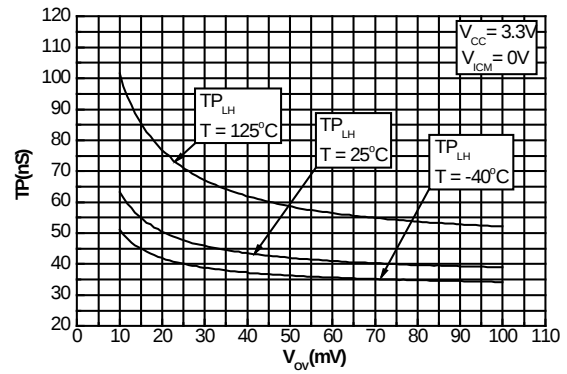


Figure 21: Propagation delay (LH) vs. overdrive at $V_{CC} = 3.3\text{ V}$, $V_{ICM} = V_{CC}$

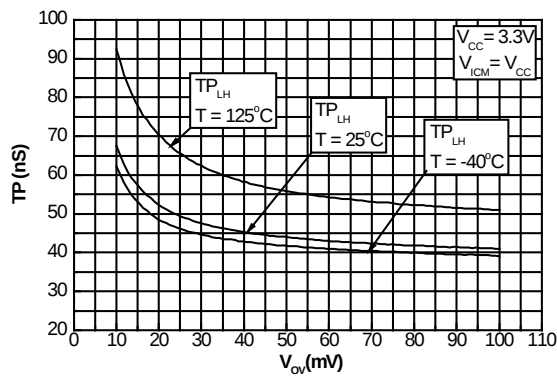


Figure 22: Propagation delay (HL) vs. overdrive at $V_{CC} = 5\text{ V}$, $V_{ICM} = 0\text{ V}$

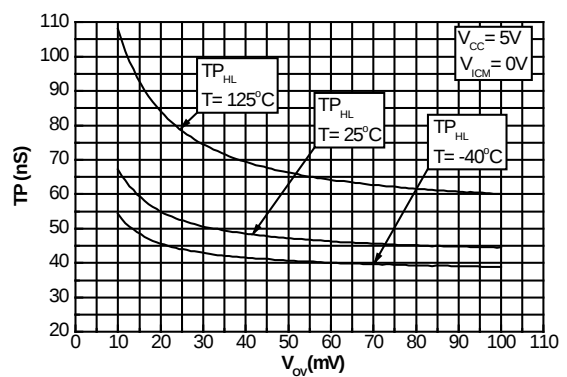


Figure 23: Propagation delay (HL) vs. overdrive at $V_{CC} = 5\text{ V}$, $V_{ICM} = V_{CC}$

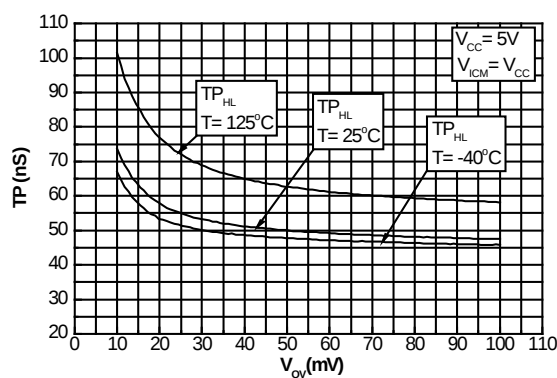


Figure 24: Propagation delay (LH) vs. overdrive at $V_{CC} = 5\text{ V}$, $V_{ICM} = 0\text{ V}$

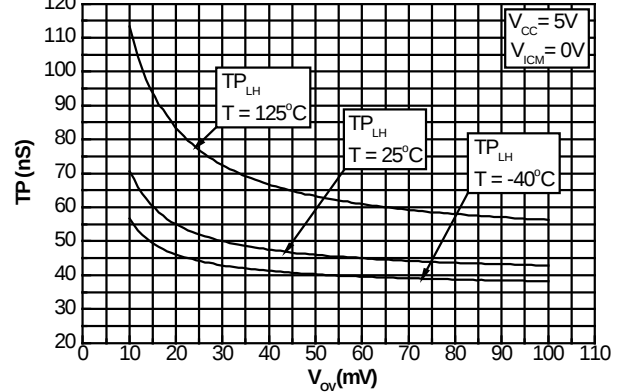


Figure 25: Propagation delay (LH) vs. overdrive at $V_{CC} = 5\text{ V}$, $V_{ICM} = V_{CC}$

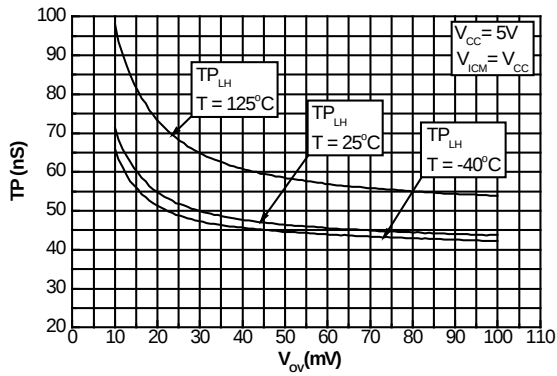


Figure 26: Propagation delay vs. temperature, $V_{CC} = 5\text{ V}$, overdrive = 100 mV

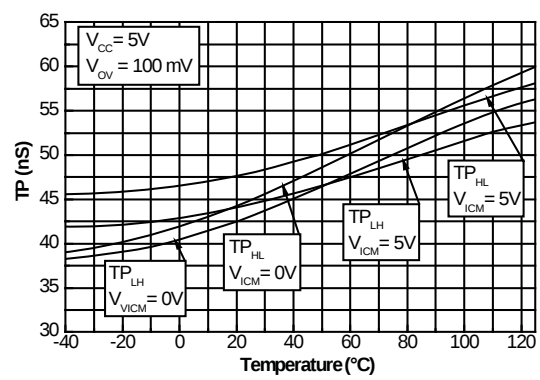
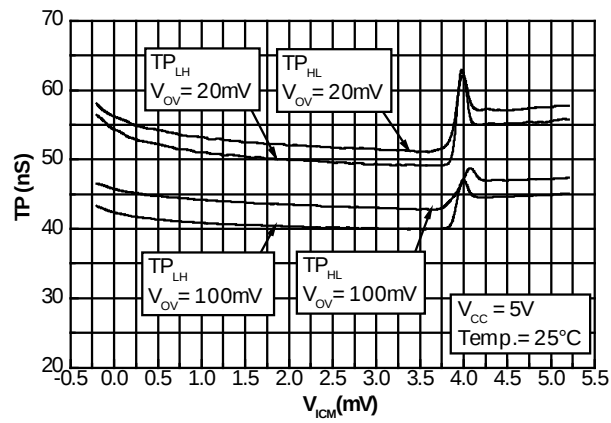


Figure 27: Propagation delay vs. common mode voltage, $V_{CC} = 5\text{ V}$



3 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK[®] is an ST trademark.

3.1 SOT23-5 package information

Figure 28: SOT23-5 package outline

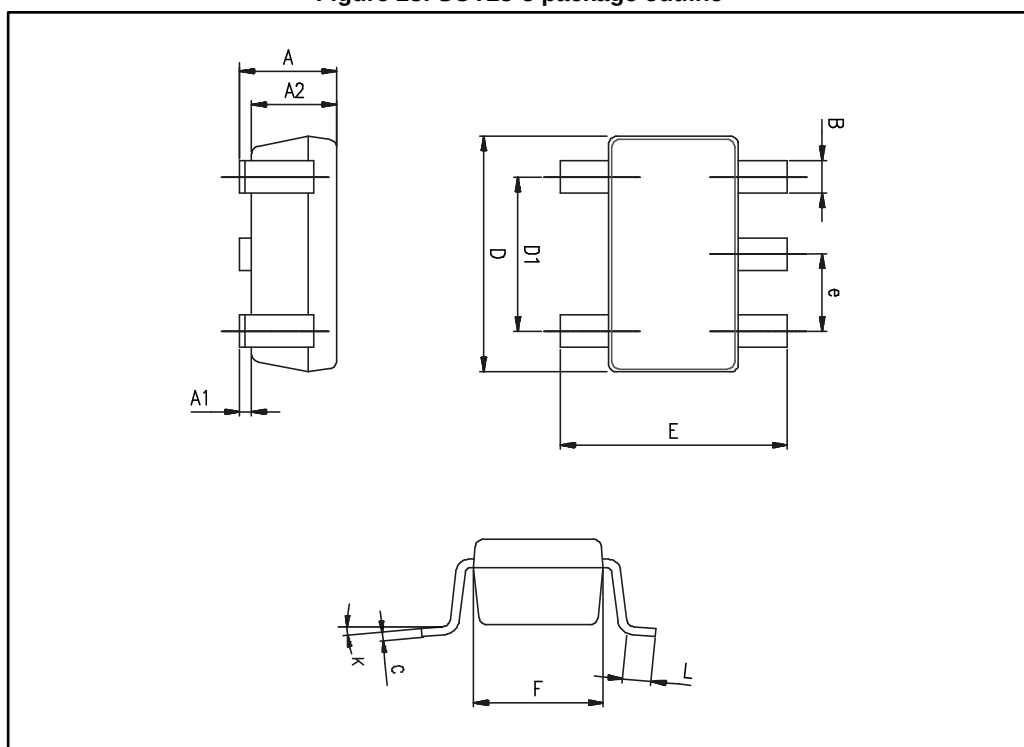


Table 6: SOT23-5 mechanical data

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	0.90	1.20	1.45	0.035	0.047	0.057
A1			0.15			0.006
A2	0.90	1.05	1.30	0.035	0.041	0.051
B	0.35	0.40	0.50	0.014	0.016	0.020
C	0.09	0.15	0.20	0.004	0.006	0.008
D	2.80	2.90	3.00	0.110	0.114	0.118
D1		1.90			0.075	
e		0.95			0.037	
E	2.60	2.80	3.00	0.102	0.110	0.118
F	1.50	1.60	1.75	0.059	0.063	0.069
L	0.10	0.35	0.60	0.004	0.014	0.024
K	0 degrees		10 degrees	0 degrees		10 degrees

3.2 SC70-5 (or SOT323-5) package information

Figure 29: SC70-5 (or SOT323-5) package outline

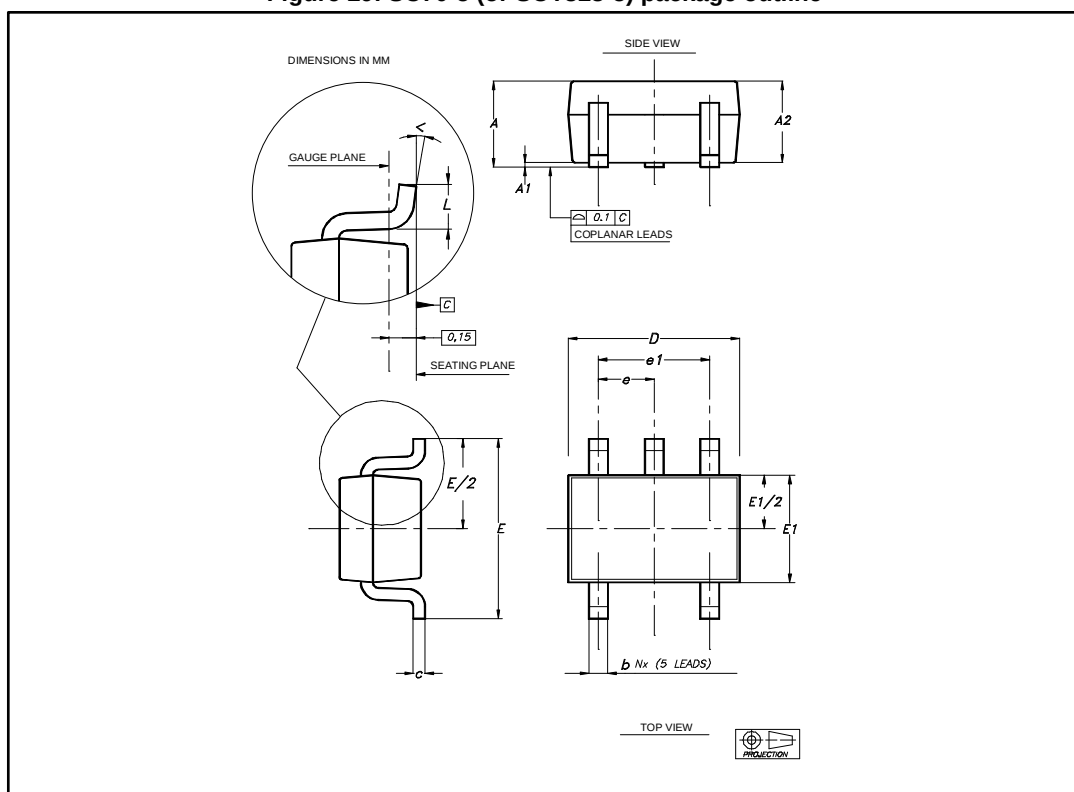


Table 7: SC70-5 (or SOT323-5) mechanical data

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	0.80		1.10	0.315		0.043
A1			0.10			0.004
A2	0.80	0.90	1.00	0.315	0.035	0.039
b	0.15		0.30	0.006		0.012
c	0.10		0.22	0.004		0.009
D	1.80	2.00	2.20	0.071	0.079	0.087
E	1.80	2.10	2.40	0.071	0.083	0.094
E1	1.15	1.25	1.35	0.045	0.049	0.053
e		0.65			0.025	
e1		1.30			0.051	
L	0.26	0.36	0.46	0.010	0.014	0.018
<	0°		8°	0°		8°

4 Ordering information

Table 8: Order codes

Order code	Temperature range	Package	Packaging	Marking
TS3021ILT	-40 to +125 °C	SOT23-5	Tape and reel	K520
TS3021IYLT ⁽¹⁾				K529
TS3021ICT		SC70-5		K52
TS3021AILT		SOT23-5		K522

Notes:

⁽¹⁾ Qualified and characterized according to AEC Q100 and Q003 or equivalent, advanced screening according to AEC Q001 and Q 002 or equivalent.

5 Revision history

Table 9: Document revision history

Date	Revision	Changes
01-Jun-2006	1	Initial release
01-Sep-2006	2	Dual version added Pinout of single TS3021 corrected Modified temperature range for input common mode voltage
22-Feb-2007	3	Addition of MiniSO-8 package for dual version
17-Oct-2007	4	Marking corrected for SO-8 package Thermal resistance values corrected in AMR table Notes on ESD added in AMR table
04-Dec-2008	5	Dual version (TS3022) removed ESD tolerance modified in Table 1: Absolute maximum ratings Made the following changes in Table 3 : – modified Vio typical value and maximum limits – modified lib typical value – modified Icc typical values and corrected maximum limits – modified Isc typical values – modified Voh and Vol typical values – modified CMRR and SVR typical values – modified TPhI and TPlh typical values All curves modified
03-Jan-2013	6	Features : added “automotive qualification”; added Related products . Table 1 and Table 2 : Vdd and Vcc replaced by (Vcc-) and (Vcc+) respectively. Table 3 , Table 4 , and Table 5 : replaced ΔV_{io} symbol with $\Delta V_{io}/\Delta T$. Table 6 and Table 7 : minor update (added angle dimensions to “inches” columns). Table 8 : added automotive order code
02-Jun-2015	7	Table 3 , Table 4 , and Table 5 : updated Vio parameter Table 6 : small “rounding-off modifications to inches parameter Table 8 : added order code TS3021AILT

IMPORTANT NOTICE – PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics – All rights reserved

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

[STMicroelectronics:](#)

[TS3021ICT](#) [TS3021ILT](#) [TS3021IYLT](#)